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Joint ICTP/IAEA Advanced School on in-situ X-ray Fluorescence and Gamma Ray Spectrometry | (smr 2064)

Tuesday 27 October 2009

<u>Methodology, advantages and limitations of in-situ XRF measurements (including overview of applications)</u> - Adriatico Guest House Giambiagi Lecture Hall (09:00-10:30)

time	title	presenter
09:00	Methodology, advantages and limitations of in-situ XRF measurements (including overview of applications)	R. PADILLA-ALVAREZ